HIGHLY SENSITIVE TIMER-BASED RESISTANCE DEVIATION TO TIME CONVERTER

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ABSTRACT: Based on an inexpensive popular precision timing chip 555 timer, a resistance to time converter is proposed in this paper it is indeed capable of converting resistive and capacitive changes into pulse widths of proportional durations. This converter exhibits a compatibility of wider conversion range with a reasonable level of sensitivity required for industrial applications. The circuit is expected to have application in oil and water supply schemes. Simulated results are shown to be compared with mathematical derivations, both reporting a good level of response matching very closely with the derived results, where a 70% deviation of an elemental value corresponds to a mismatch of 50-70 micro-seconds between derived and simulation results.

ABSTRAK: Rintangan kepada penukar masa berdasarkan cip pemasaan tepat dan murah yang popular 555, telah dicadangkan dalam kertas kerja ini. Ia memang mampu menukarkan perubahan perintang dan pemuat kepada lebar nadi jangka masa berkadar. Penukar ini mempamerkan keserasian pelbagai penukaran yang lebih luas dengan tahap sensitiviti yang munasabah untuk aplikasi perindustrian. Litar ini dijangka mempunyai applikasi dalam skim bekalan minyak dan air. Keputusan simulasi dibandingkan dengan terbitan matematik, kedua-duanya menunjukkan keputusan yang sangat rapat, di mana 70% daripada nilai asas berkaitan dengan tidak sepadan 50-70 mikro-saat antara keputusan simulation dan terbitan matematik.

KEYWORDS: resistance to pulse converters; linearity; sensitivity; resistance to frequency converters

1. INTRODUCTION

In monitoring, automation and control, small resistive changes can emmulate the physical parameter of our interest such as force, displacement, vibration, and temperature. Conversion of resistive changes into corresponding time period or frequency changes has been presented since very long. Such conversions have been one of the most reliable and significant measurement steps in resistive transducers applications commonly used in today's industry. Their application is on the rise particularly in cases of automation and control being carried out wirelessly through small distances such as narrow gaps.

Resistance to time (or frequency) converters of critical importance in small measurements activities. These measurements have been traditionally carried out by transducers normally exhibiting linear precise responses over a limited range. When carried out over a wide range, such transducers usually start showing nonlinear responses, which results in inaccuracies. Such inaccuracies were not considered noticeable when looked from the traditional transducers' view point, where even sizeable errors were overlooked. However, in today's smart applications the overlooked ignorable mismatches are considered unaffordable. Therefore, it is crucial to implement a circuit which would be able to produce a linear as well as highly sensitive output.

Various papers have presented and proposed converter circuit that can be implemented in the transducer to produce a linear as well as highly sensitive output. Two main papers of interest are [1-2] which presented the circuit by implementing Wheatstone bridge as well as amplifier bridge. In these papers, the effect of offset error and its compensation is being discussed to show that linearity improves with offset compensation scheme.

The first paper by Mochizuki and Watanabe [1] implemented a relaxation oscillator with the combination of the Wheatstone bridge resistor. Wheatstone is implemented due to its ability to detect small changes in terms of resistance deviations as compared to the early implementation of relaxation oscillator [1]. However, nonlinearity characteristic starts to appear when the period is amplified due to time-delay which is onward solved by using compensation techniques.

The second paper by S. Kaliyugavaradan [2] proposed a refined version of the circuit which not only rules out the need for using compensation arrangement, but also provided grounded transducer.

This paper refines the existing works with by implementing a monostable circuit to produce the same resistance deviation to frequency converter with improved linearity and sensitivity over a wider range. This paper will attempt to prove the reliability of using monostable circuit by presenting the results of the output as compared to the theoretical derivations.

2. STATE OF THE ART WORK

Making use of a bridge, reference [1] suggests a resistance to frequency converter with a resolution of 0.05% and linearity maintained over a given range. The offset error produced by the OP AMP used is a major obstacle, which is addressed by the feedback of a fraction of the output. The suggested circuit has signal processing applications.

A linear resistance-to-time converter with high resolution has been reported [2]. The results obtained had a good level of linearity with the nonlinearity error less than $\pm 0.1\%$ over the range of 950 Ω - 2950 Ω and the conversion sensitivity of 50 µs/ Ω .

Another highly quoted paper [3], proposes a resistance-to-time converter which is also implemented on a resistive bridge configuration. Over a resistance deviation range of 0-2 Ω , the converter exhibits a response with nonlinearity error less than 0.005 %. Further, it is reported to have exhibited a conversion sensitivity of 2832.4 µs/ Ω .

All the above converters are suggesting custom built electronic approaches, which on occasions will be making it challenging task, considering the availability of the required components. This converter uses a 555-timer connected in a monostable mode. This circuit produce small resistance variations as pulse-width conversions through the use of a 555-timer, that can be made easily available avoiding the requirement of custom-built electronic conversion circuit. The challenges are to obtain a high level of linearity and better conversion sensitivity over a wider range of resistance deviation.

3. THEORY AND SIMULATION OF PROPOSED RESISTANCE TO TIME CONVERTER

The circuit diagram of Fig. 1(a) is a basic mono-stable multi-vibrator, also called 'one-shot' pulse generation circuit which uses a 555 IC timer circuit. The external resistor and capacitor (RC) network is connected between power supply and ground. An input trigger pulse is applied to trigger input pin (Pin4) of the timer which is normally kept at high. The output of the mono-stable multi-vibrator remains at low before it is triggered. As the trigger pin turns low the timer generate a pulse at the output for a period which is equal to the value of its time constant (values of external resistor and capacitor used). The duration of the resulting pulse can be theoretically derived as given in following equation.

$$T=1.17RC$$
 (1)



Fig. 1: (a) 555-Timer Based Monostable Pulse Generator (b) Output Pulse of 555-Timer Based Monostable Pulse Generator.

In another configuration Fig. 2 (a), two mono-stable circuits are used and connected in parallel. The same values are used for the external resistor and capacitor, having equal time constants, and as shown in Fig. 2(b), no pulse is produced as a result.

(a)





Fig. 2: (a) Two mono-stable circuits connected in parallel, (b) No pulse generated.

In another such configuration Fig. 3 (a), the two mono-stable circuits are connected in parallel similar to that shown in Fig. 2. Keeping capacitance the same, the resistance values are kept different for two unequal time constants. So, they do produce a pulse at the output of the exclusive-OR gate with width given by

$$T = 1.17(R_2 - R_1)C \tag{2}$$

(a)





Fig. 3:(a) Two mono-stable circuits connected in parallel for resistive deviations (b) Generated output pulse of two mono-stable circuits connected in parallel with resistive deviations (3 Ω).

The final arrangement is presented in Fig. 4(a). Unlike the circuit of Fig. 3, in this circuit each mono-stable circuit has used resistors of equal values while two capacitors of dissimilar values. Ultimately this slightly modified arrangement attempts to produce pulse of a width given by

$$T = 1.17 R(C2-C1)$$
(3)





Fig. 4: (a). Two mono-stable circuits connected in parallel for capacitive deviation (b). Generated pulse of two mono-stable circuits connected in parallel for capacitive deviation $(49 \ \mu F)$.

4. SIMULATION RESULTS AND DISCUSSION

The proposed circuit has highlighted the conversion of a small resistance changes into narrow pulse widths (microsecond range). The relationship between these changes appears to be linear over a certain range of resistive and capacitive variations. In Figure 5(a) Pulsewidth versus percentage resistance deviation and while in Figure 5(b) Pulse-width versus Percentage capacitive deviations are shown respectively. These plots are derived from data given in Table 1 and 2 respectively (see **APPENDIX I**). The simulation plots generated using MATLAB confirm with the mathamatical equations.



Fig. 5: (a) Pulse width versus percentage resistance deviation (in Ω).

For resistance changes of up to 10 Ω , a pulse width of 200 µs is produced. The maximum width of pulse is about 1400 µs when the resistance deviation is near to about 100%. sensitivity of 20 µs/ Ω is obtained over this resistive deviation. It is apparent that the converter's sensitivity is of a poorer value than [8] but has shown a good level of linearity over a much wider range of 0-60 Ω (0-100%). Further increase of resistive values shows a nonlinear response.



Fig. 5 (b): Pulse width versus Percentage capacitive deviation (μ F)

Comparing the response shown Fig. 5(b), the conversion of pulse width with percentage increase in capacitive changes shows a direct linear behavior over the ranges 0-90 μ F range. A variation of 100 μ s pulse width is generated for a cpacitive change of 10 μ F, giving a sensitivity of 10 μ s/ μ F is obtained over the described range of 0-90 μ F.

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From the resulting plots given above it is obvious that the size of the pulse width obtained is dependent on resistance and capacitance values respectively. Although this conversion of resistive and capacitive changes do not produce subsequent time width of same size, both the suggested circuits behaved in a linear fashion over a time under consideration. The results of this work can be applied in converting small resistive or capacitive changes into their pulses of width equivalent to corresponding changes. The same concepts might be useful for signal extract from embedded transducers as such concepts is the foundation principal of pulse-width-modulation (PWM). Further, the resolution and sensitivity of the circuits under consideration could be adjusted to application specific case study requirements.

5. CONCLUSION

A new design of resistance deviation to frequency converter utilizing a monostable circuit 555-timer is presented in this paper. From the simulation results, it is evident that the proposed converter circuit produce a good level of linearity of up to 100% ranges with sensitivity of 20 μ s/ Ω and 10 μ s/ μ F for resistance and capacitance variations respectively. Unlike conventional circuits, this converter avoids using integrator, oscillator and bridge circuits. This simple converter is tolerent to offers better performance in terms of linearity and wider rage of daviations and is suitable for applications in the oil and water treatment industry

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Table 1								
S.No	R ₁ (Ω)	R ₂ (Ω)	Change in R (Ω)	C (µF)	Mathematical Value 1.17 (R ₁ - R ₂)C (us)	Simulated Result (µs)	Percentage Resistance variation	
1	47	47	0	20	0	0	0	
2	47	48	1	20	23.4	22	1.67	
3	47	49	2	20	46.8	45	3.33	
4	47	50	3	20	70.2	67.5	5.00	
5	47	51	4	20	93.6	89	6.67	
6	47	52	5	20	117	110	8.33	
7	47	53	6	20	140.4	132.5	10.00	
8	47	54	7	20	163.8	155	11.67	
9	47	55	8	20	187.2	176	13.33	
10	47	56	9	20	210.6	197.5	15.00	
11	47	57	10	20	234	219.5	16.67	
12	47	58	11	20	257.4	241	18.33	
13	47	59	12	20	280.8	264	20.00	
14	47	60	13	20	304.2	285	21.67	
15	47	61	14	20	327.6	308.5	23.33	
16	47	62	15	20	351	329.5	25.00	
17	47	63	16	20	374.4	353	26.67	
18	47	64	17	20	397.8	372.5	28.33	
19	47	65	18	20	421.2	395	30.00	
20	47	66	19	20	444.6	417.5	31.67	
21	47	67	20	20	468	439	33.33	
22	47	68	21	20	491.4	462	35.00	
23	47	69	22	20	514.8	483	36.67	
24	47	70	23	20	538.2	508	38.33	
25	47	71	24	20	561.6	527	40.00	
26	47	72	25	20	585	545	41.67	
27	47	73	26	20	608.4	565	43.33	
28	47	74	27	20	631.8	592	45.00	
29	47	75	28	20	655.2	614	46.67	
30	47	76	29	20	678.6	637	48.33	
31	47	77	30	20	702	658	50.00	
32	47	78	31	20	725.4	680	51.67	
33	47	79	32	20	748.8	702	53.33	
34	47	80	33	20	772.2	723	55.00	
35	47	81	34	20	795.6	744	56.67	
36	47	82	35	20	819	763	58.33	
37	47	83	36	20	842.4	790	60.00	
38	47	84	37	20	865.8	812	61.67	
39	47	85	38	20	889.2	833	63.33	

APPENDIX I

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912.6	857	65.00
936	878	66.67

40	47	86	39	20	912.6	857	65.00
41	47	87	40	20	936	878	66.67
42	47	88	41	20	959.4	898	68.33
43	47	89	42	20	982.8	920	70.00
44	47	90	43	20	1006.2	942	71.67
45	47	91	44	20	1029.6	964	73.33
46	47	92	45	20	1053	988	75.00
47	47	93	46	20	1076.4	1004	76.67
48	47	94	47	20	1099.8	1036	78.33
49	47	95	48	20	1123.2	1052	80.00
50	47	96	49	20	1146.6	1066	81.67
51	47	97	50	20	1170	1100	83.33
52	47	98	51	20	1193.4	1100	85.00
53	47	99	52	20	1216.8	1130	86.67
54	47	100	53	20	1240.2	1160	88.33

Table 2.

S.No	C ₁ (µF)	C ₂ (µF)	Change in C (µF)	R (Ω)	Mathematical Value 1.17 (C ₂ - C ₁)R (µs)	Simulated Result (µs)	Percentage capacitance variation
1	10	10	0	10	0	0	0.00
2	10	11	1	10	11.7	11.6	1.67
3	10	12	2	10	23.4	22.2	3.33
4	10	13	3	10	35.1	33.5	5.00
5	10	14	4	10	46.8	44	6.67
6	10	15	5	10	58.5	55.5	8.33
7	10	16	6	10	70.2	66.4	10.00
8	10	17	7	10	81.9	77.2	11.67
9	10	18	8	10	93.6	87.4	13.33
10	10	19	9	10	105.3	98.8	15.00
11	10	20	10	10	117	109.6	16.67
12	10	21	11	10	128.7	122	18.33
13	10	22	12	10	140.4	132	20.00
14	10	23	13	10	152.1	144	21.67
15	10	24	14	10	163.8	155	23.33
16	10	25	15	10	175.5	165	25.00
17	10	26	16	10	187.2	175	26.67
18	10	27	17	10	198.9	185	28.33
19	10	28	18	10	210.6	195	30.00
20	10	29	19	10	222.3	209	31.67
21	10	30	20	10	234	219.5	33.33
22	10	31	21	10	245.7	230	35.00
23	10	32	22	10	257.4	240	36.67

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	1.0			10	• (•)		
24	10	33	23	10	269.1	251	38.33
25	10	34	24	10	280.8	261	40.00
26	10	35	25	10	292.5	272.5	41.67
27	10	36	26	10	304.2	282.5	43.33
28	10	37	27	10	315.9	297.5	45.00
29	10	38	28	10	327.6	306	46.67
30	10	39	29	10	339.3	320	48.33
31	10	40	30	10	351	330	50.00
32	10	41	31	10	362.7	339.25	51.67
33	10	42	32	10	374.4	350	53.33
34	10	43	33	10	386.1	362	55.00
35	10	44	34	10	397.8	372	56.67
36	10	45	35	10	409.5	383	58.33
37	10	46	36	10	421.2	395	60.00
38	10	47	37	10	432.9	405	61.67
39	10	48	38	10	444.6	418	63.33
40	10	49	39	10	456.3	430	65.00
41	10	50	40	10	468	440	66.67
42	10	51	41	10	479.7	450	68.33
43	10	52	42	10	491.4	460	70.00
44	10	53	43	10	503.1	470	71.67
45	10	54	44	10	514.8	480	73.33
46	10	55	45	10	526.5	495	75.00
47	10	56	46	10	538.2	504	76.67
48	10	57	47	10	549.9	514	78.33
49	10	58	48	10	561.6	524	80.00
50	10	59	49	10	573.3	534	81.67
51	10	60	50	10	585	547.44	83.33
52	10	61	51	10	596.7	547.44	85.00
53	10	62	52	10	608.4	547.44	86.67
54	10	63	53	10	620.1	547.44	88.33